

**Notice of References Cited**

Application/Control No.

09/935,493

Applicant(s)/Patent Under  
Reexamination  
SMALLEY ET AL.

Examiner

Elena Tsoy

Art Unit

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Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0092613	07-2002	Kuper, Cynthia A.	156/296
	B	US-			
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	D	US-			
	E	US-			
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	L	US-			
	M	US-			

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	N	EP 989579 A2	03-2000	European Patent	BOWER et al.	H01J 01/30
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**NON-PATENT DOCUMENTS**

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	U	Tohji et al , Fullerene Sci. Technol. 7 (1999) 65
	V	Shaffer et al, Adv. Mater. 1999, 11(11), 937-941x
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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